

Synthesis of alicyclic polymers for 157 nm photoresists by Pd²⁺ catalyzed vinyl addition polymerization

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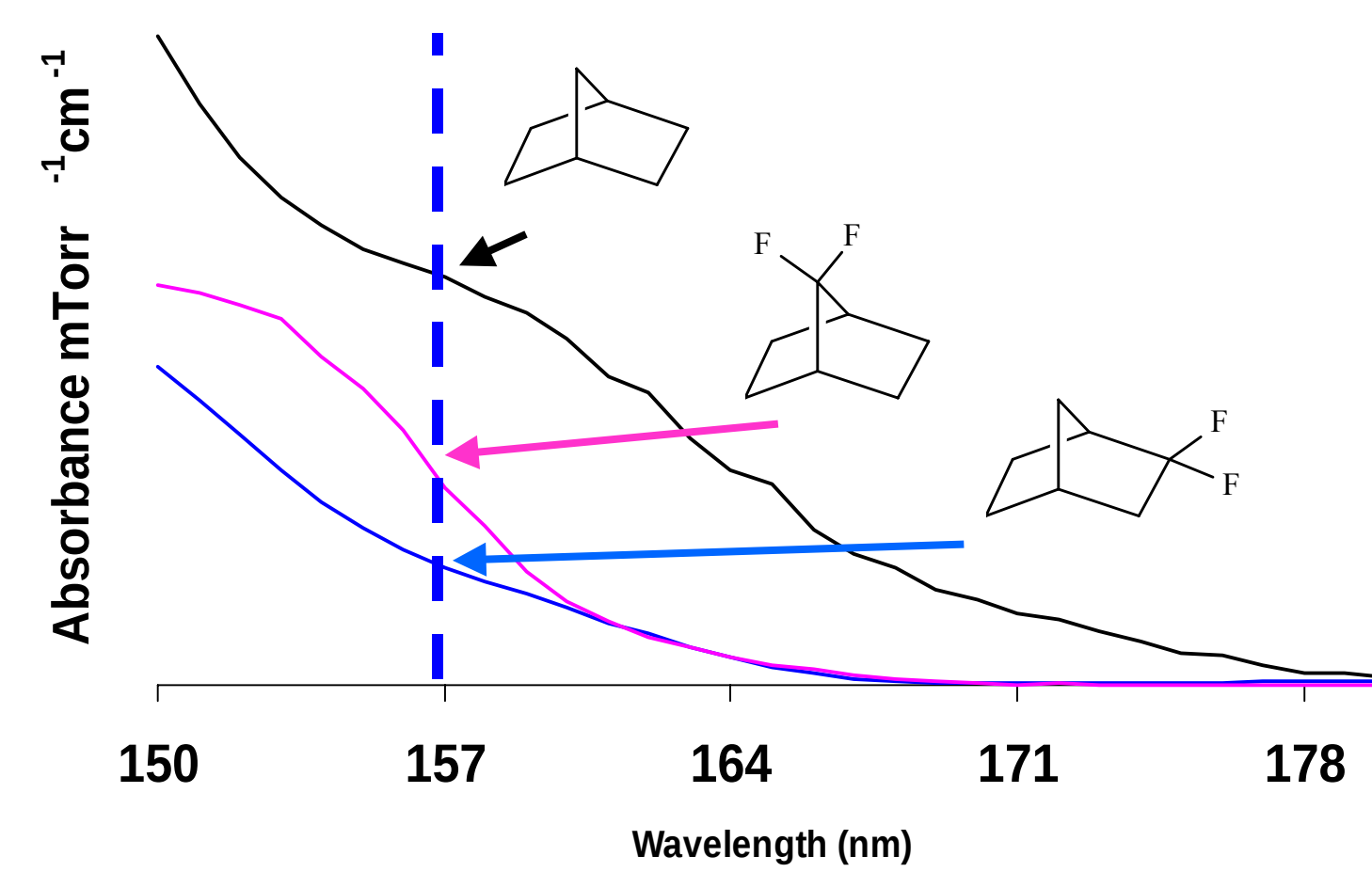
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Introduction:

The development of 157 nm photoresists is proceeding at a frenzied pace. Many relatively transparent fluorocarbon monomers have been synthesized and studied and a variety of polymerization methods have been reported.¹ This poster reports the synthesis of a 157 nm resist platform² based upon alicyclic polymers synthesized by allyl palladium catalyzed addition polymerization. One of the major advantages in using palladium catalysts is the ability to produce polymers with low and controlled molecular weights. However, one challenge in synthesizing functionalized alicyclic polymers for photoresists by cationic palladium catalysts is the cleavage of the acid labile *t*-butyl ester protecting group by strong acid that is generated during the polymerization. We have found that polymer-bound, sterically hindered pyridines, or "proton sponges", can be utilized to neutralize residual acid without decreasing the catalyst activity and the proton sponge easily removed by simple filtration after the polymerization. Poly (bicyclo[2.2.1]hept-5-ene-2-carboxylic acid *tert*-butyl ester-co-bicyclo[2.2.1]hept-5-ene-2-(1,1,1-trifluoro-2-trifluoromethylpropan-2-ol)) was successfully polymerized by palladium catalysis with proton sponges. Imaging work with this polymer system will be discussed.

- (a) Chiba, T.; Hung, R.; Yamada, S.; Trinqu, B.; Yamachika, M.; Brodsky, C.; Patterson, K.; Vander Heyden, A.; Jamison, A.; Lin, S. H.; Somervell, M.; Byers, J.; Conley, W.; Willson, C. G. *J. Photopolym. Sci. Technol.* **2000**, *13*, 657-664. (b) Ito, H.; Wallraff, G. M.; Brock, P.; Fender, N.; Truong, H.; Breyta, G.; Miller, D. C.; Sherwood, M. H.; Allen, R. D. *Proc. SPIE* **2001**, 4345-31.
- Hung, R. J.; Tran, H. V.; Trinqu, B. C.; Chiba, T.; Yamada, S.; Sanders, D. P.; Connor, E. F.; Grubbs, R. H.; Klopp, J.; Frechet, J. M. J.; Thomas, B. H.; Shafer, G.; DesMarteau, D. D.; Conley, W.; Willson, C. G. *Proc. SPIE* **2001**, 4345-43.

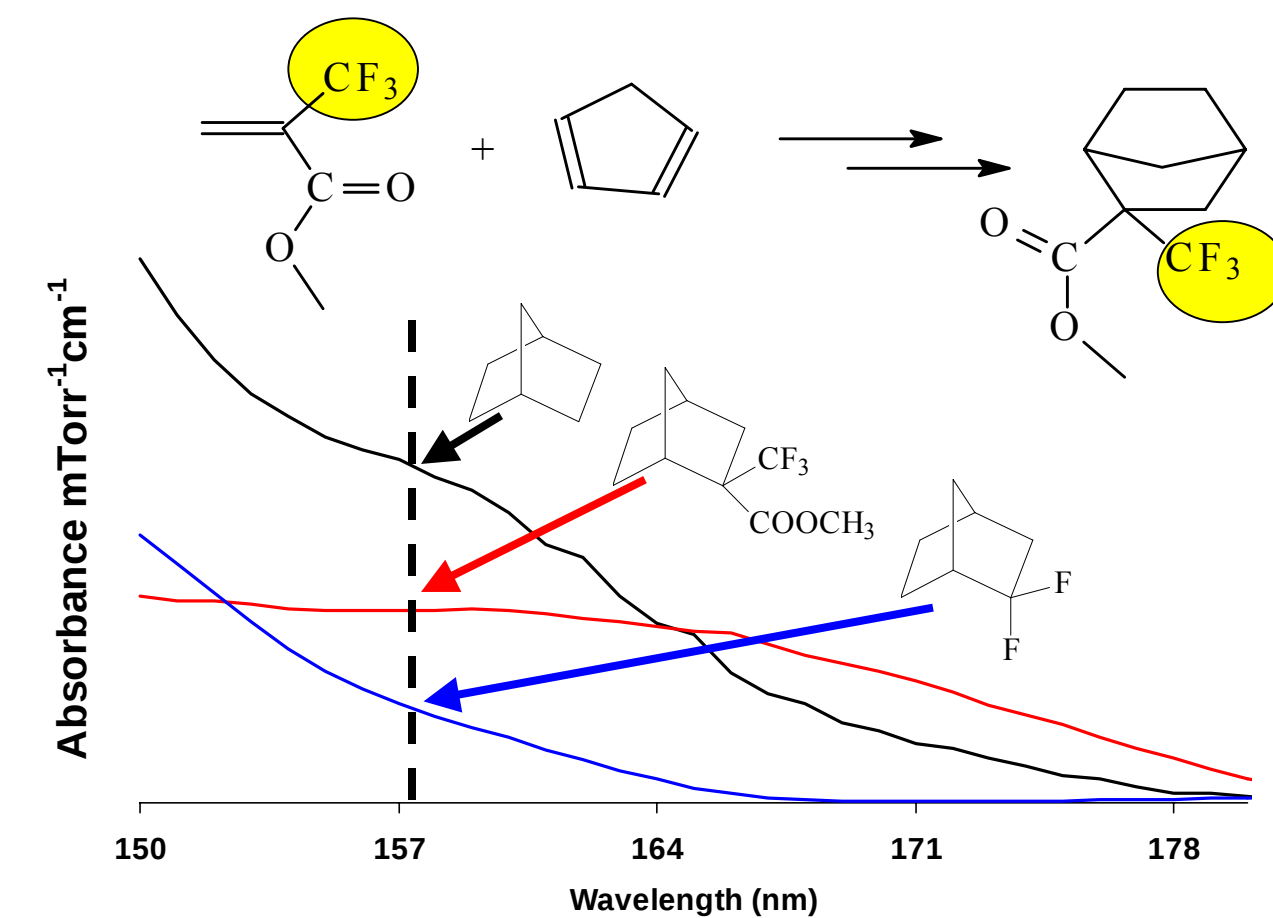
Selective Fluorination of Norbornane



Geminal substitution at the two carbon bridge is the most effective fluorination pattern

T. Chiba, et. al., *J. Photopolym. Sci. Technol.*, *13* (2000) 657-664

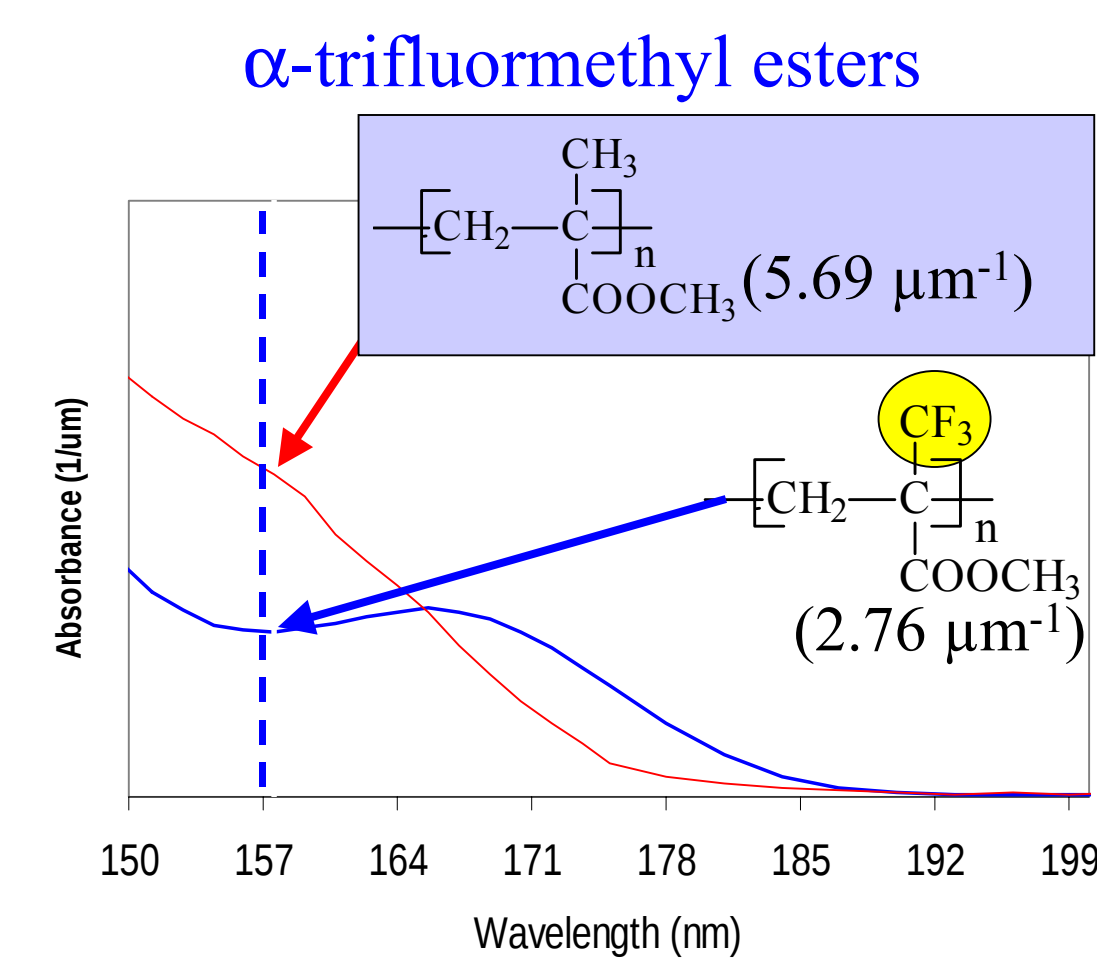
Gas-Phase UV Measurement of the α -CF₃ substituted norbornane



The α -CF₃ substituted norbornane – improved transparency

T. Chiba, et. al., *J. Photopolym. Sci. Technol.*, *13* (2000) 657-664

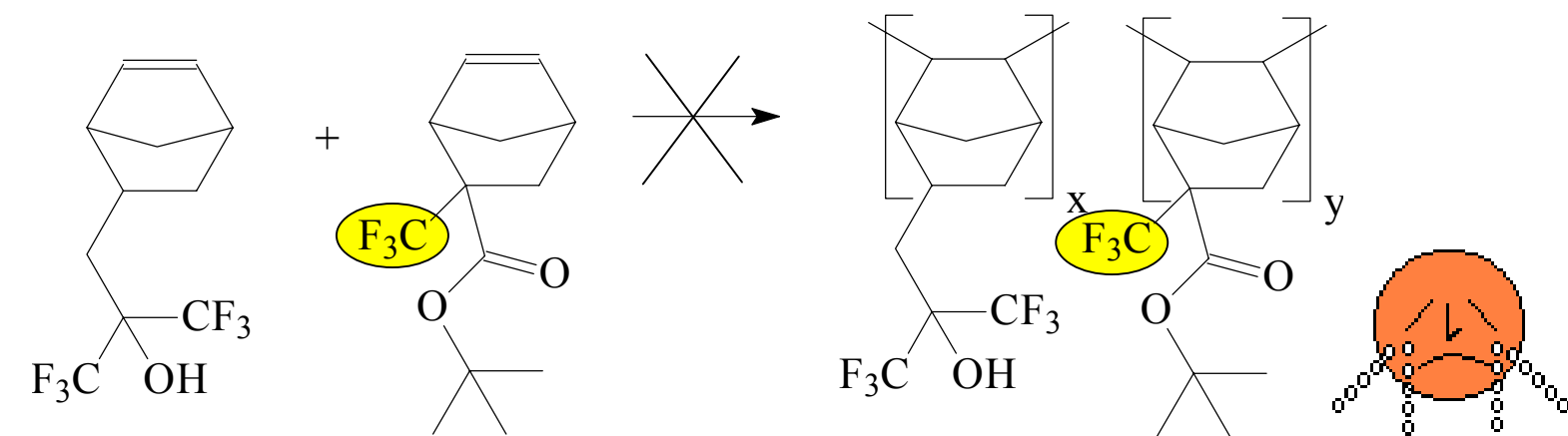
Carboxylic Acids can be Acidic Groups for 157 Resist



Addition of α -CF₃ group reduces the absorbance of ester at 157 nm

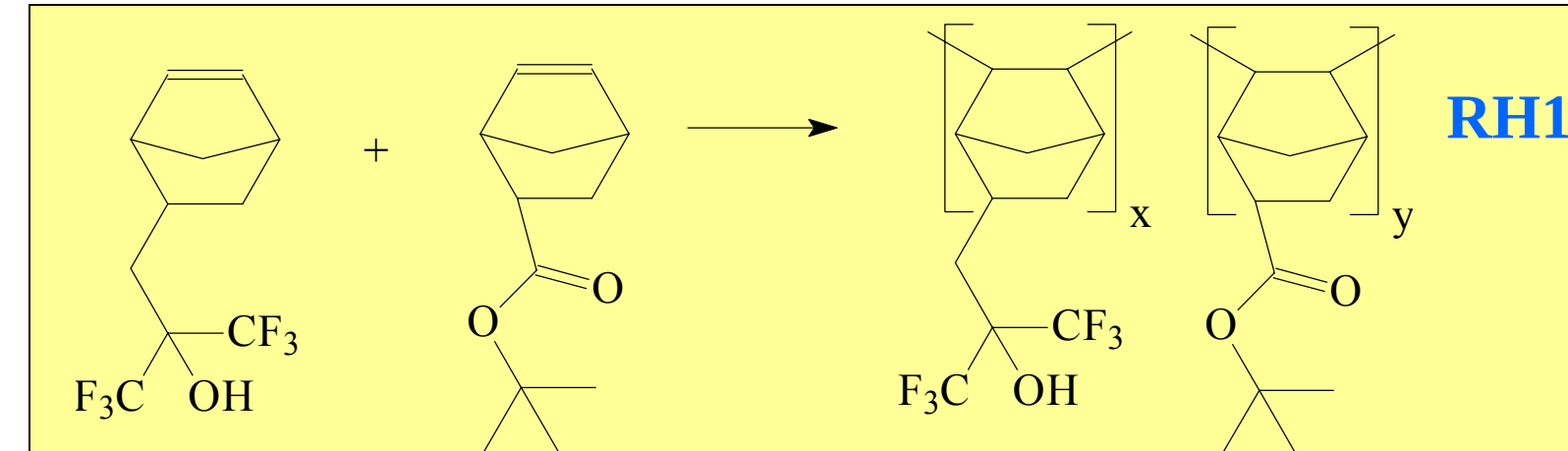
T. Chiba, et. al., *J. Photopolym. Sci. Technol.*, *13* (2000) 657-664

Polymers for Imaging at 157 nm

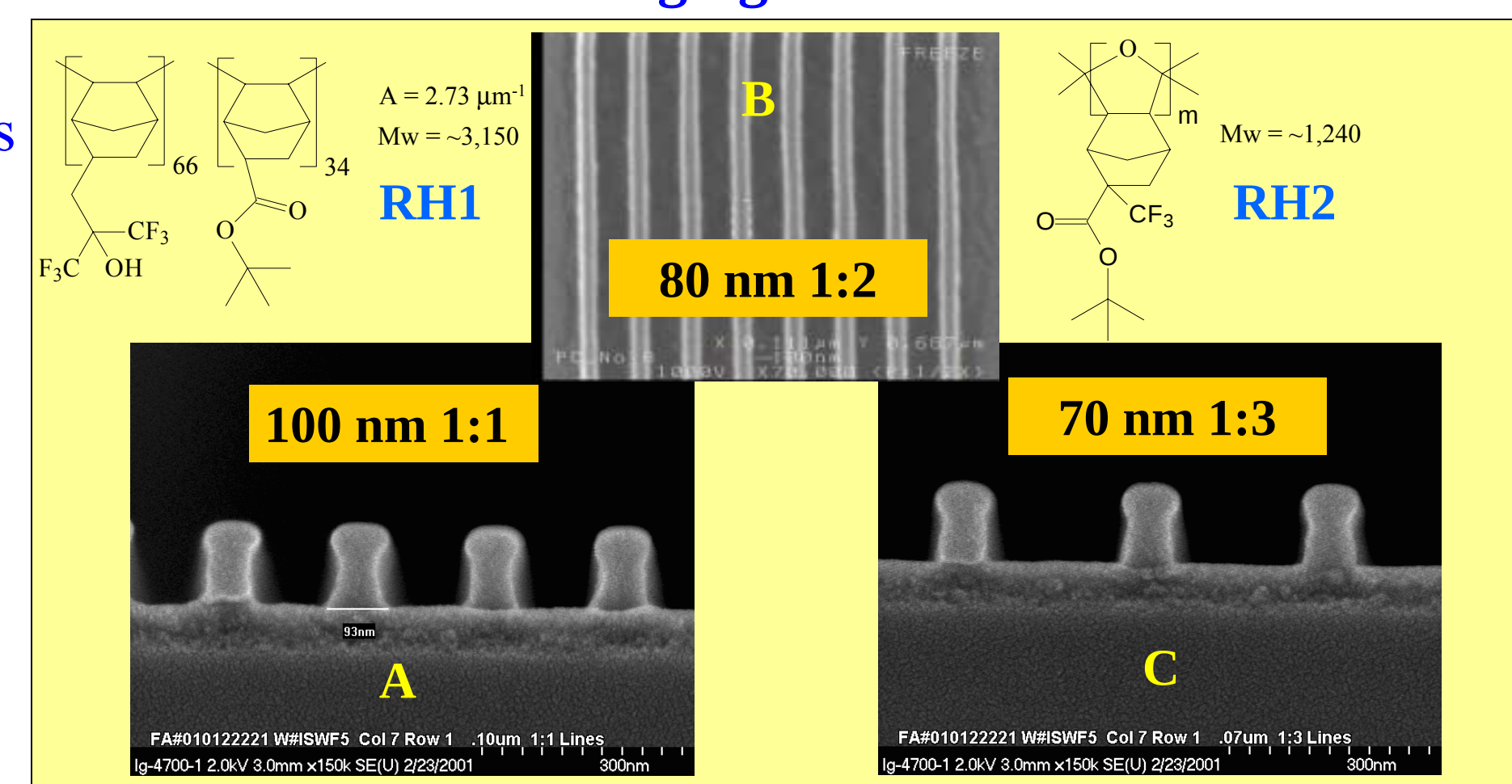


Unfortunately, we can not copolymerize these transparent monomers

Compromise with the less transparent monomer for imaging



Imaging Results



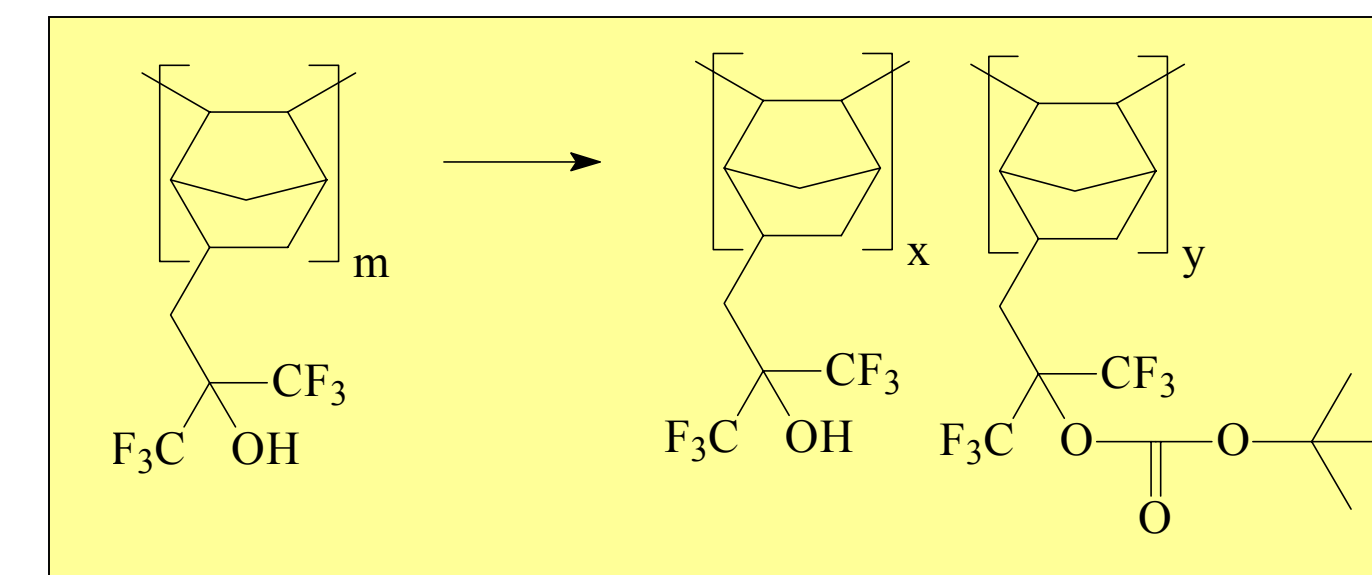
Formulation:
A: 50/50 blend of 80/20 vinyl addition copolymer RH1 with CO copolymers RH2 (D1)
B: C: 70/30 blend of 70/30 vinyl addition copolymer RH1 with CO copolymers RH2 (D1)
Conditions:
157 nm exposure (0.6NA-0.3g, 50 mJ/cm²), phase shift mask, 148 nm thick resist on 70 nm anti-reflective layer (DUV30), 140°C-60s PAB, 130°C-90s PEB, 20 sec 0.26N TMAH development.

Another Alicyclic polymer platform:

NorBornene HexaFluoroalcoh (NBHFOH)-co-t-BOC platform

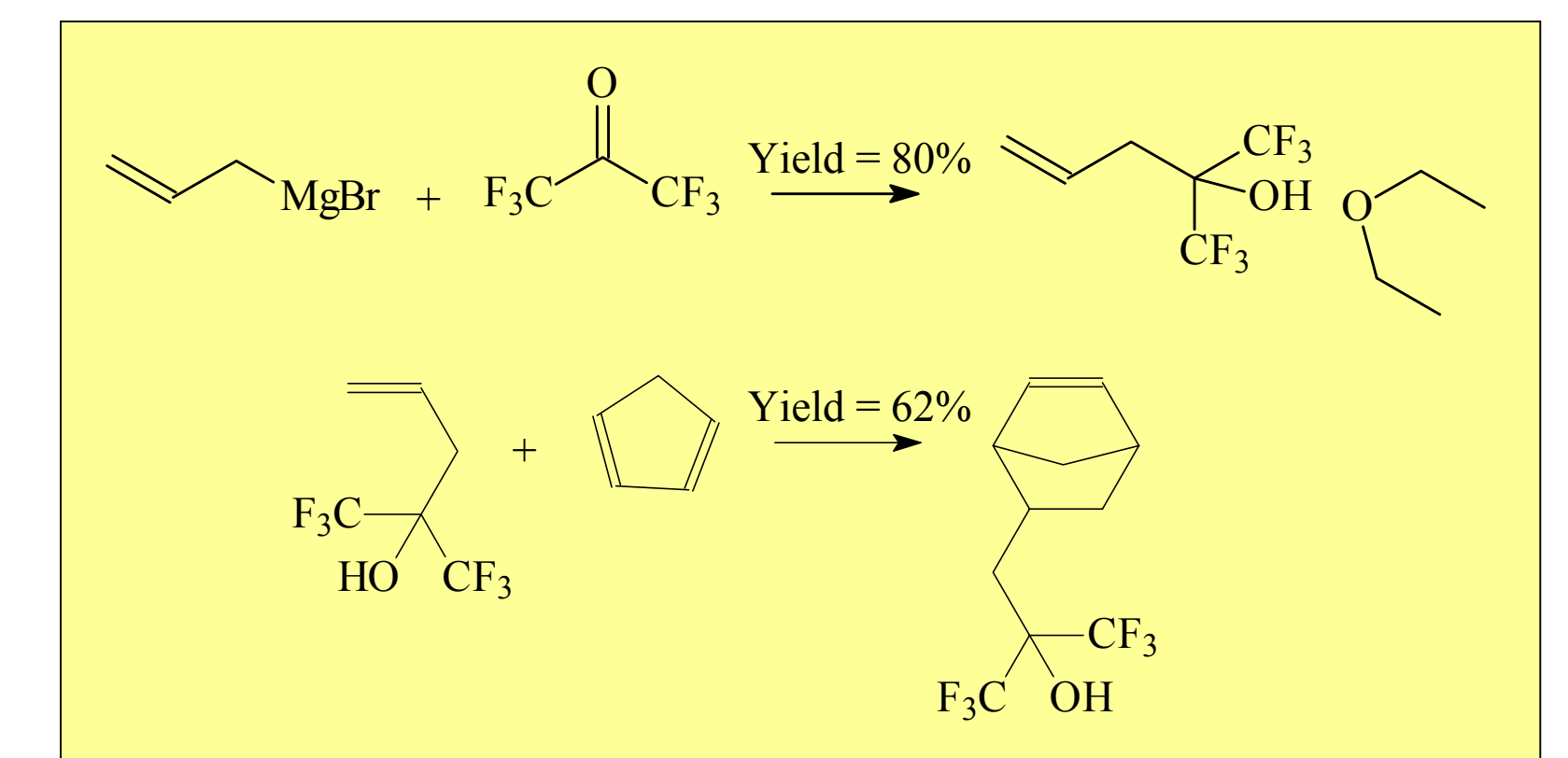
NBHFOH-co-TCN platfrom (Please see TCN poster)

NorBornene HexaFluoroalcoh (NBHFOH)-co-t-BOC platform

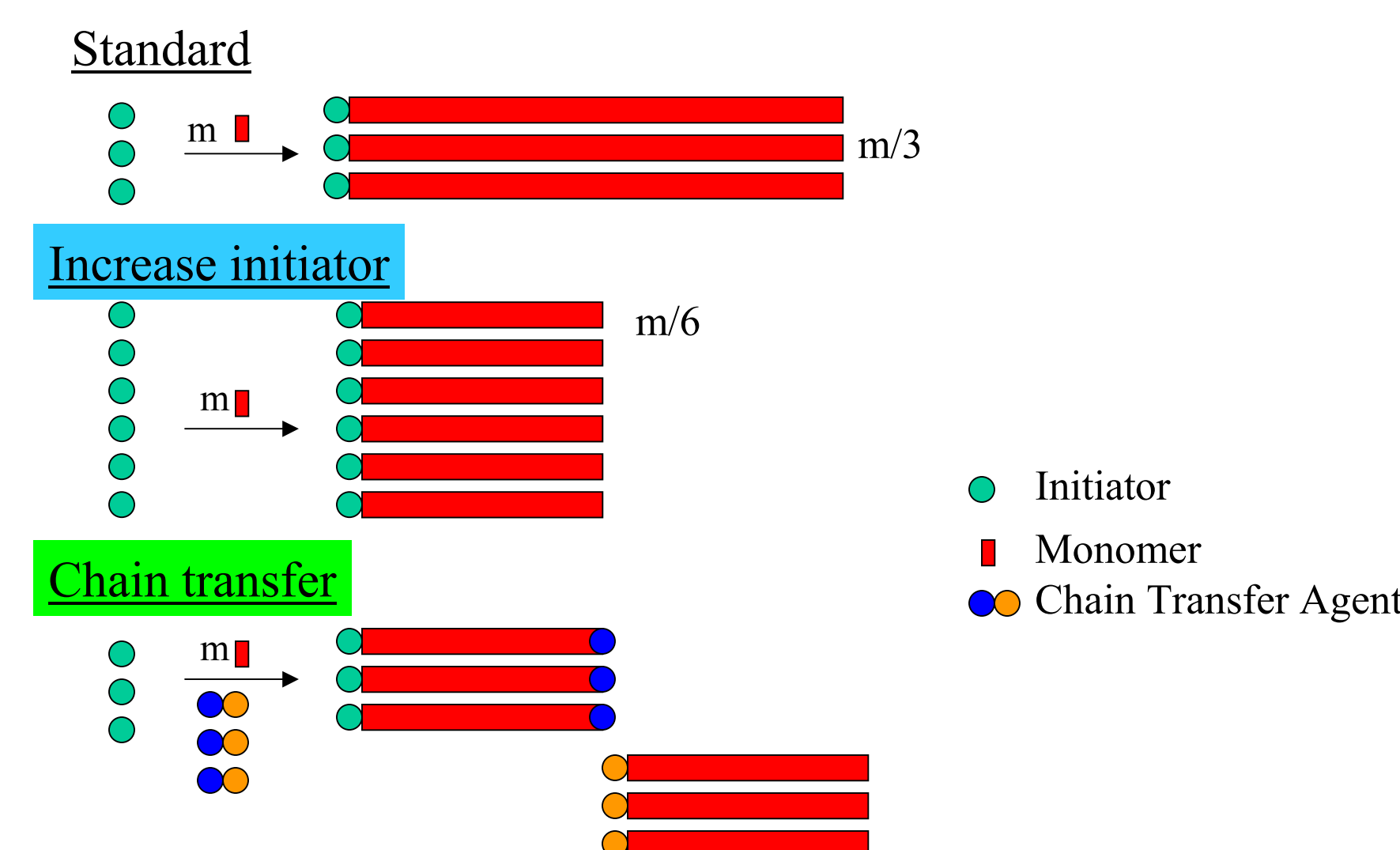


- Excellent optical transparency
- Poor contrast
- High molecular weight → Swelling

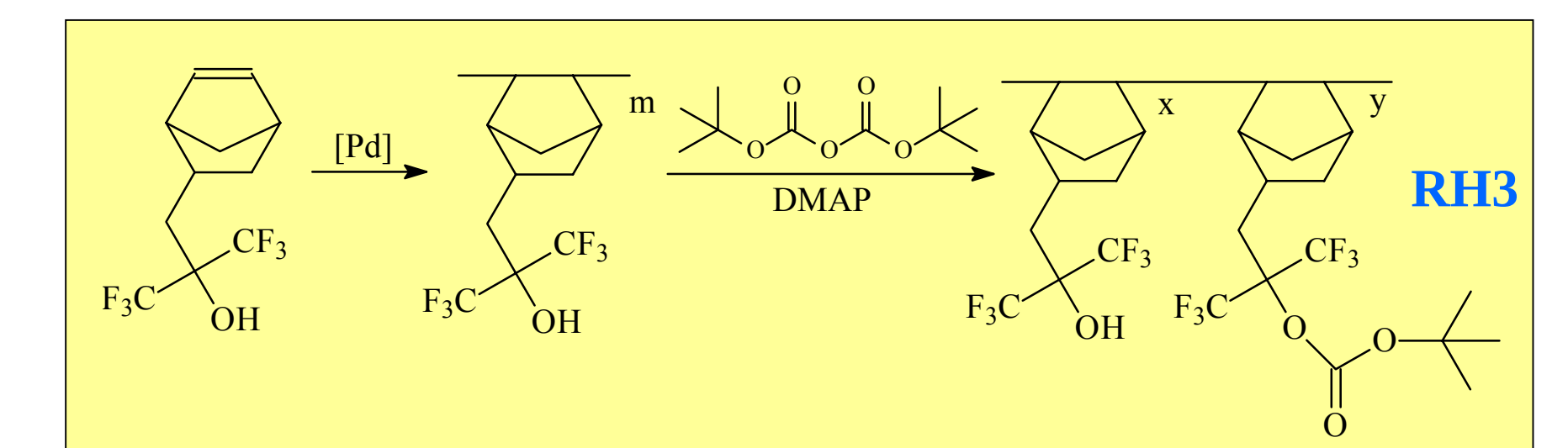
Synthesis of Bicyclo[2.2.1]hept-5-ene-2-(1,1,1-trifluoro-2-trifluoromethylpropan-2-ol)



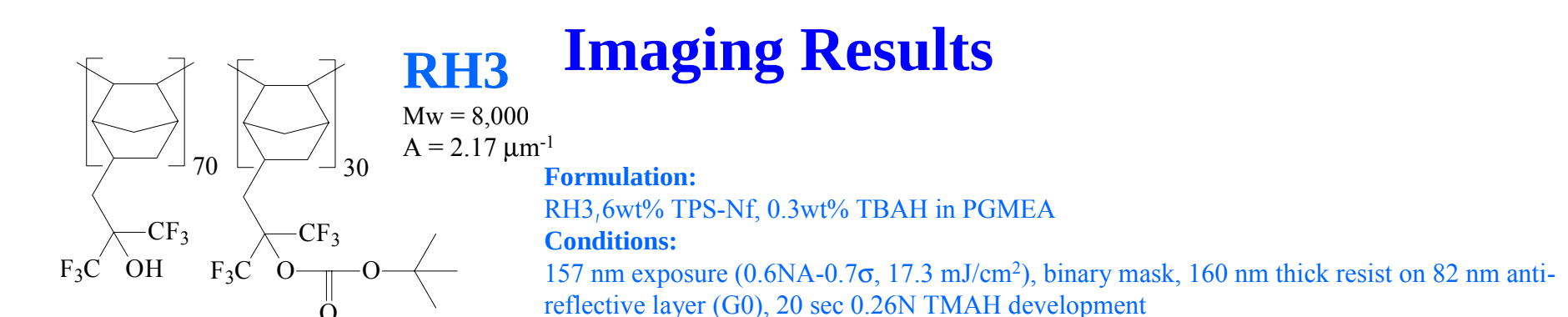
Reduction of MW



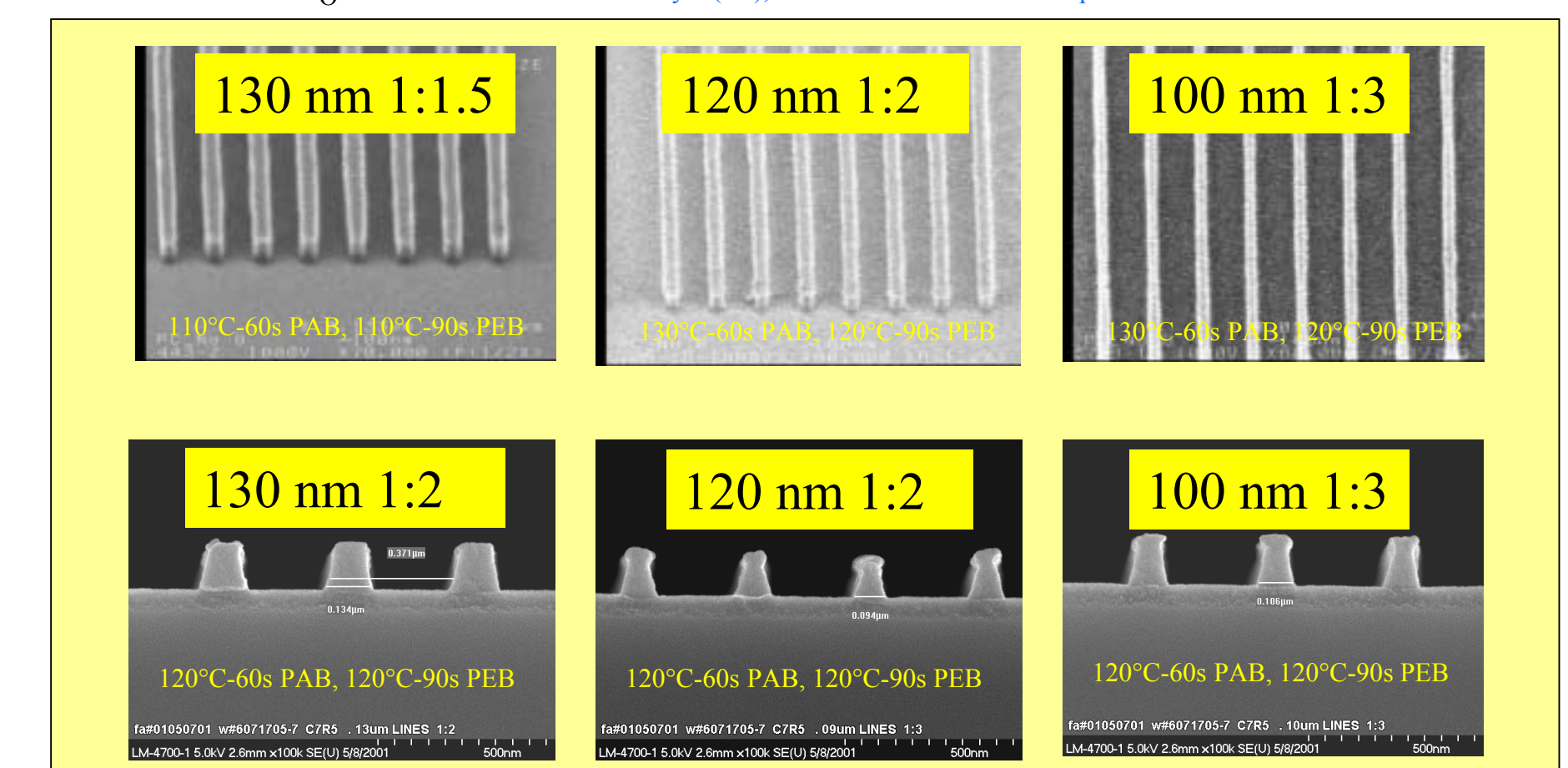
Improvement Plan



Increase the catalyst loading
↓
Lower the molecular weight
↓
Acceptable images



Imaging Results



Conclusion:

This platform looks promising. Its has excellent optical transparency, we propose to print images with higher aspect ratios. This material is very new. We are still exploring the optimal polymer composition ratio and the process conditions for sub-100 nm features.

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